	Application No.	Applicant(s)
	10/091 966	BUTLER ET AL.
Notice of Allowability	10/081,866 Examiner	Art Unit
•	Davienne Monbleau	2878
The MAILING DATE of this communication apperatus All claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIOF of the Office or upon petition by the applicant. See 37 CFR 1.313	(OR REMAINS) CLOSED in this ap or other appropriate communication IGHTS. This application is subject t	plication. If not included n will be mailed in due course. THIS
1. $\boxtimes$ This communication is responsive to <u>the response filed on</u>	<u>9/13/04</u> .	
2. The allowed claim(s) is/are <u>1-47</u> .		
3. A The drawings filed on 22 February 2002 are accepted by the	he Examiner.	
<ul> <li>4. Acknowledgment is made of a claim for foreign priority ur</li> <li>a) All b) Some* c) None of the:</li> <li>1. Certified copies of the priority documents have</li> <li>2. Certified copies of the priority documents have</li> <li>3. Copies of the certified copies of the priority do International Bureau (PCT Rule 17.2(a)).</li> <li>* Certified copies not received:</li> </ul>	e been received. e been received in Application No	<del></del>
Applicant has THREE MONTHS FROM THE "MAILING DATE" noted below. Failure to timely comply will result in ABANDONN THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.	of this communication to file a reply IENT of this application.	complying with the requirements
5. A SUBSTITUTE OATH OR DECLARATION must be subm INFORMAL PATENT APPLICATION (PTO-152) which give	itted. Note the attached EXAMINER es reason(s) why the oath or declara	S'S AMENDMENT or NOTICE OF ation is deficient.
6. CORRECTED DRAWINGS ( as "replacement sheets") mus	st be submitted.	
(a) ☐ including changes required by the Notice of Draftspers		-948) attached
1)  hereto or 2)  to Paper No./Mail Date		
(b) ☐ including changes required by the attached Examiner's Paper No./Mail Date	s Amendment / Comment or in the C	Office action of
Identifying indicia such as the application number (see 37 CFR 1 each sheet. Replacement sheet(s) should be labeled as such in t	.84(c)) should be written on the drawi he header according to 37 CFR 1.121(	ngs in the front (not the back) of
7. DEPOSIT OF and/or INFORMATION about the depo attached Examiner's comment regarding REQUIREMENT	sit of BIOLOGICAL MATERIAL I FOR THE DEPOSIT OF BIOLOGIC	must be submitted. Note the AL MATERIAL.
Attachment(s)  1. ☑ Notice of References Cited (PTO-892)		Patent Application (PTO-152)
2. Notice of Draftperson's Patent Drawing Review (PTO-948)	6.	
<ul> <li>3. ☑ Information Disclosure Statements (PTO-1449 or PTO/SB/0 Paper No./Mail Date 2/7/03; 6/2/03</li> <li>4. ☐ Examiner's Comment Regarding Requirement for Deposit</li> </ul>	8), 7. ⊠ Examiner's Amendi	ment/Comment ent of Reasons for Allowance
of Biological Material	9. ☐ Other	on of reasons for Allowance

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EXAMINER'S COMMENTS, AMENDMENT, AND STATEMENTS OF REASONS FOR ALLOWANCE

## Election/Restrictions

Applicant's election without traverse of Group I in the reply filed on 9/13/04 is acknowledged. However, after further consideration, Examiner has decided to withdraw the previous election requirement. Therefore, all pending claims (Claims 1-47) will be examined on the merits.

## Information Disclosure Statement

The IDS filed on 2/7/03 and 6/2/03 have been acknowledged and a signed copy of each PTO-1449 is attached herein.

### Examiner's Amendment

An examiner's amendment to the record appears below. Should the changes and/or additions be unacceptable to applicant, an amendment may be filed as provided by 37 CFR 1.312. To ensure consideration of such an amendment, it MUST be submitted no later than the payment of the issue fee.

The application has been amended as follows:

Claim 6 line 1: insert - detector - after "said depth". (Examiner believes that this was unintentionally omitted.)

# Allowable Subject Matter

Claims 1-47 are allowed.

The following is an examiner's statement of reasons for allowance:

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Regarding Claims 1-10 and Claims 23-32, the cited prior of record does not teach or fairly suggest an alignment detector comprising, along with the other claimed features, one or more optical elements each aligned to receive a respective laser beam in said one or more laser beams, wherein said one or more optical elements are adapted to convert said one or more laser beams into a plurality of laser outputs.

Regarding Claims 11-17 and 33-42, the cited prior of record does not teach or fairly suggest a depth detector comprising, along with the other claimed features, one or more optical elements each aligned to receive a respective laser beam in said one or more laser beams, wherein said one or more optical elements are adapted to convert said one or more laser beams into one or more sets of laser outputs.

Regarding Claims 18-22 and 43-47, the cited prior of record does not teach or fairly suggest a level detector comprising, along with the other claimed features, one or more optical elements each aligned to receive a respective laser beam in said one or more laser beams, wherein said one or more optical elements are adapted to provide a set of laser planes.

The cited prior art of record (*Heintzeman*) teaches mounting a laser onto a drill to provide alignment, but does not teach providing more than one laser output. The cited prior art of record (*Olds*) also teaches that more than one laser source can be used to determine the alignment of a drill with respect to a mark on a work piece. However, although *Olds* teaches in column 3 lines 56-61 using optical lenses to convert a pencil beam from the laser to a projected fan beam, there is no teaching of an optical element to create more than one laser output. Lastly, the cited prior art of record (*Summerer*) teaches that a semiconductor wafer may have an alignment mark comprising two sets of parallel lines, wherein the sets are orthogonal to one another. However,

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Summerer does not teach that the alignment illumination beams (208 and 210) each converted into more than one beam via an optical element. (Regarding Claims 11-17 and 33-42, it is also important to note that "sets of laser outputs" requires that each set has more than one laser output: Merriam-Webster's Collegiate Dictionary 10<sup>th</sup> Ed. definition 21 – a set is a "collection of elements".)

The advantages of these features are in the specification on pages 1-4.

#### Conclusion

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

The prior art made of record and not relied upon is considered pertinent to applicant's disclosure:

Heintzeman (US 6,375,395) teaches a laser mounted on the casing of a drill such that the laser is in line with the bit and pointing in the reverse direction, which allows the laser to be used to align the drill bit with a mark or hole such that the drill bit is directly in line with the preexisting mark.

Olds (US 5,741,096) teaches a line laser assisted alignment apparatus that uses two laser line generators to define a reference axis that is aligned to coincide with an axis of a drill bit or other rotational tool.

Summerer (US 6,537,836) teaches an optical system for scanning an alignment illumination comprising a pair of orthogonal lines impinging light of the surface of an alignment

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mark on a semiconductor wafer, wherein said alignment mark comprises two sets of parallel lines that are orthogonal to each other.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Davienne Monbleau whose telephone number is 571-272-1945. The examiner can normally be reached on Mon-Fri 9:00 am to 5:00 pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Dave Porta can be reached on 571-272-2444. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent.

Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

DNM

Parienne Monbleau

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